

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination	
* 1 0 7 3 5 6 7 9 *	10/735,679	KURITA ET AL.	
	Examiner	Art Unit	
	Rick K. Chang	3729	

SEARCHED			
Class	Subclass	Date	Examiner
search	updated	2/23/2006	RC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR